

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/821,298	YAMANAKA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Cong-Lac Huynh	2178	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,490,592	12-2002	St. Denis et al.	707/102
*	B	US-6,377,259	04-2002	Tenev et al.	345/440
*	C	US-2002/0023089	02-2002	Woo, Thomas Y.	707/101
*	D	US-2002/0174201	11-2002	Ramer et al.	709/220
*	E	US-2002/0083032	06-2002	Bourges-Sevenier, Mikael	707/1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.